FORM PTO-1449 LIST OF PATENTS AND EDELICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT S

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (if known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
/NB/	A1	US 2004/0055892 A1	03/25/2004	Oh et al.		

APPLICANTS: HASTWELL et al.

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (if known)	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
/NB/	A2	WO 03/062456 A1	07/31/2003	Japan		Corresponding U.S. patent
/NB/	A3	JP 04-086602	03/19/1992	Japan		Abstract only

EXAMINER INITIAL	OTHER ART - NON PATENT LITERATURE DOCUMENTS (Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.				
/NB/	A4	Steward et al., "NanoXerography: The Use of Electrostatic Forces to Pattern Nanoparticles," Proceedings of the 2003 NSF Design, Service and Manufacturing Grantees and Research Conference, pp. 1-7.			

EXAMINER	/Naravan Bhat/	DATE CONSIDERED	03/27/2008	
	,		03/2//2000	

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